

P-Channel Enhancement Mode Power MOSFET

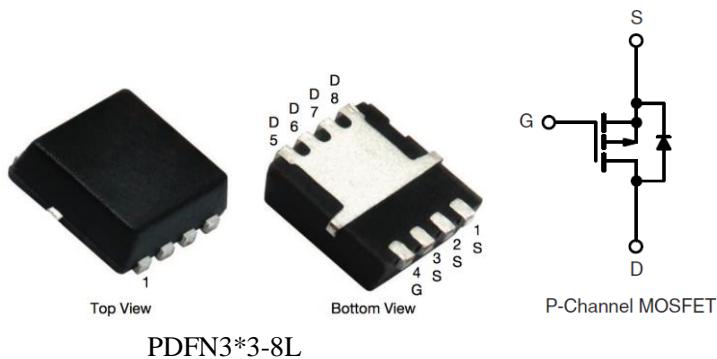
- Features

V_{DS}	$R_{DS(ON)TYP}$	I_D
-20V	6.5 mΩ@-4.5V	-65A
	8 mΩ@-2.5V	

- General Description

- load switch
- battery protection applications

- Pin Configurations



PDFN3*3-8L

- Absolute Maximum Ratings @ $T_A=25^\circ C$ unless otherwise noted

Parameter		Symbol	Ratings	Unit
Drain-Source Voltage		V_{DSS}	-20	V
Gate-Source Voltage		V_{GSS}	± 12	V
Drain Current (Continuous) *AC	$T_c=25^\circ C$	I_D	-65	A
	$T_c=100^\circ C$		-41	
Drain Current (Pulse) *B		I_{DM}	-260	A
Single Pulse Avalanche Energy *L=0.5mH, $I_{AS}=-19A$		E_{AS}	90	mJ
Power Dissipation	$T_c=25^\circ C$	P_D	52	W
Operating Temperature/ Storage Temperature		T_J/T_{STG}	-55~150	°C

- Thermal Resistance Ratings

Parameter		Symbol	Maximum	Unit
Maximum Junction-to-Ambient	Steady State	R_{thJC}	2.4	°C/W

Electrical Characteristics

$T_A=25^\circ\text{C}$ unless otherwise noted

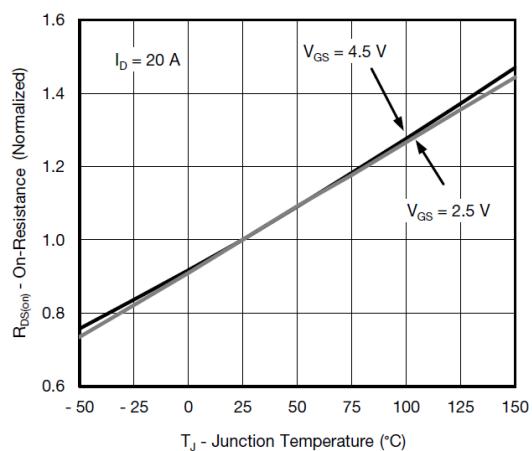
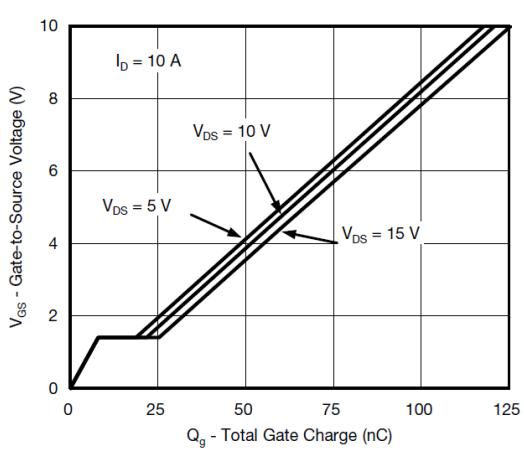
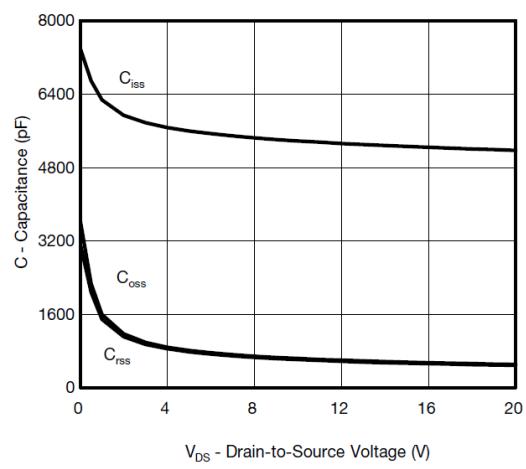
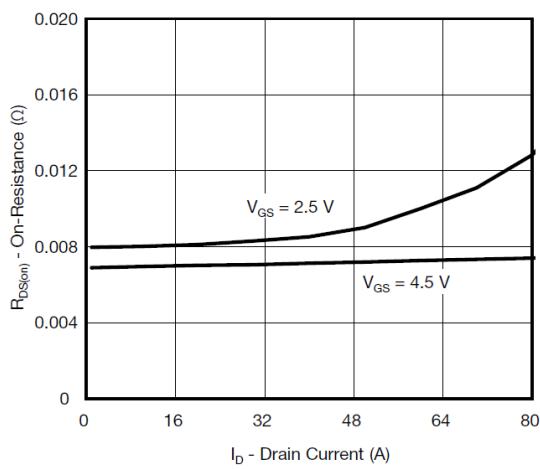
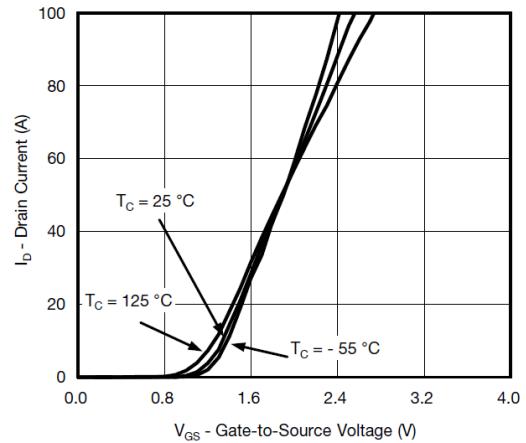
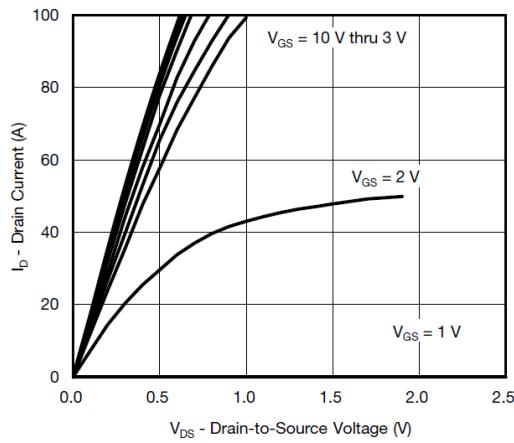
Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = -250\mu\text{A}$	-20	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -20V, V_{GS} = 0V$	--	--	-1	μA
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{GS} = V_{DS}, I_{DS} = -250\mu\text{A}$	-0.3	-0.65	-1	V
Gate Leakage Current	I_{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$	--	--	± 100	nA
Drain-Source On-state Resistance	$R_{DS(\text{on})}$	$V_{GS} = -4.5V, I_D = -20\text{A}$	--	6.5	8	$\text{m}\Omega$
	$R_{DS(\text{on})}$	$V_{GS} = -2.5V, I_D = -20\text{A}$	--	8	11	$\text{m}\Omega$
Diode Forward Voltage	V_{SD}	$I_{SD} = -10\text{A}, V_{GS} = 0V$	--	-0.8	-1.2	V
Diode Forward Current *AC	I_s	$T_c = 25^\circ\text{C}$	--	--	-65	A
Switching						
Total Gate Charge	Q_g	$V_{GS} = -4.5V, V_{DS} = -10V, I_D = -10\text{A}$	--	57	--	nC
Gate-Source Charge	Q_{gs}		--	8	--	nC
Gate-Drain Charge	Q_{gd}		--	14	--	nC
Turn-on Delay Time	$t_{d(on)}$	$V_{GS} = -10V, V_{DS} = -10V, R_L = 1\Omega, R_g = 1\Omega$	--	12	--	ns
Turn-on Rise Time	t_r		--	10	--	ns
Turn-off Delay Time	$t_{d(off)}$		--	80	--	ns
Turn-Off Fall Time	t_f		--	10	--	ns
Dynamic						
Input Capacitance	C_{iss}	$V_{DS} = -10V, V_{GS} = 0V, f = 200\text{kHz}$	--	5600	--	pF
Output Capacitance	C_{oss}		--	600	--	pF
Reverse Transfer Capacitance	C_{rss}		--	635	--	pF

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

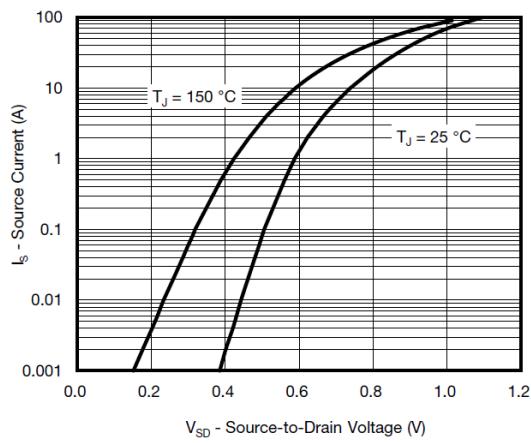
B: Repetitive rating, pulse width limited by junction temperature.

C: The current rating is based on the $t \leq 10\text{s}$ junction to ambient thermal resistance rating.

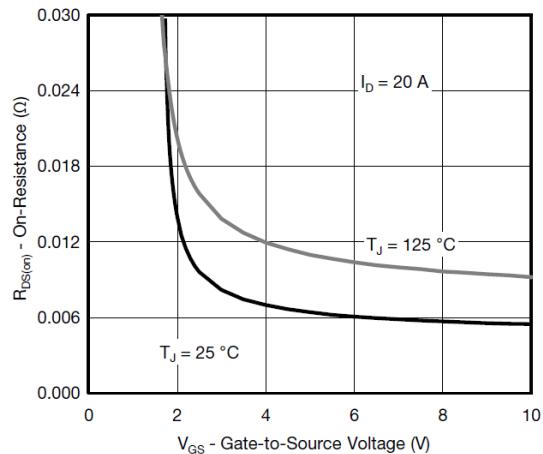
Typical Electrical and Thermal Characteristics



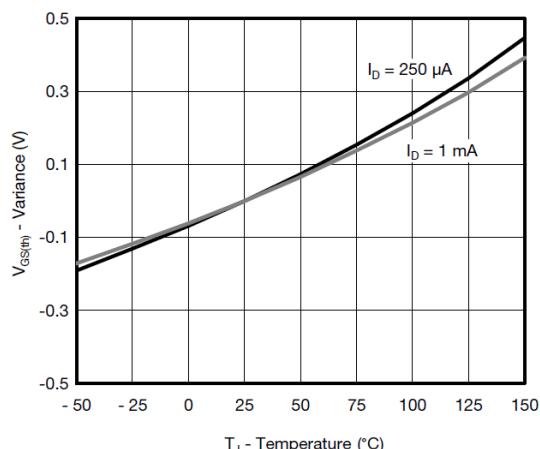
Typical Electrical and Thermal Characteristics



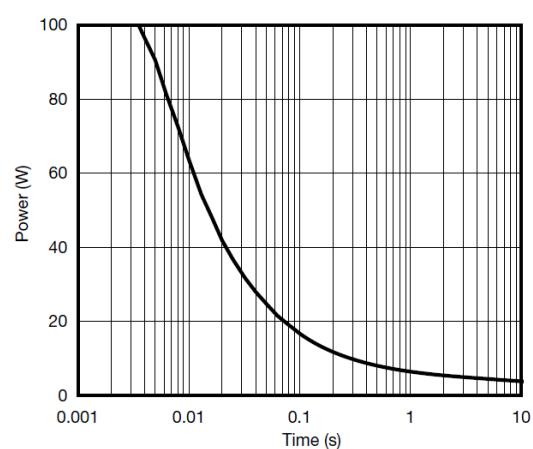
Source-Drain Diode Forward Voltage



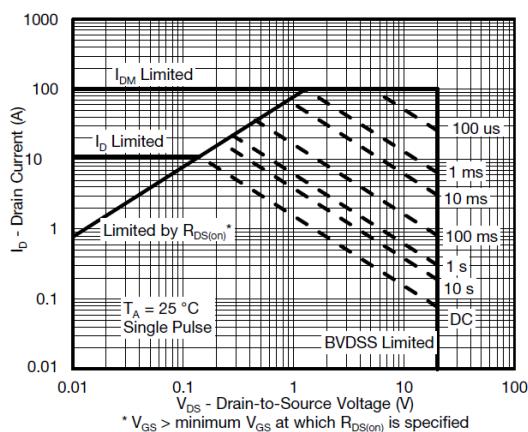
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

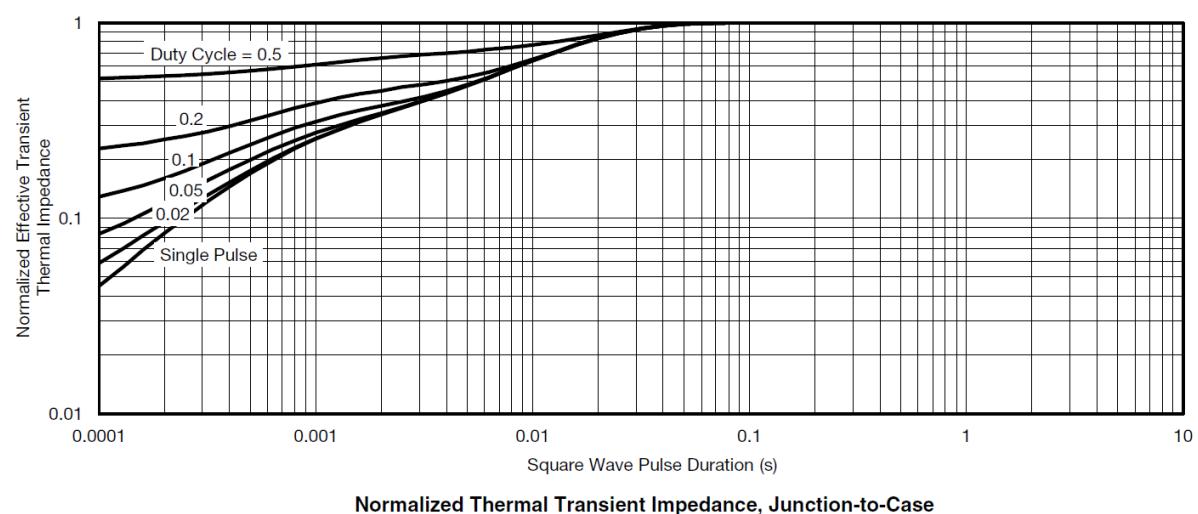
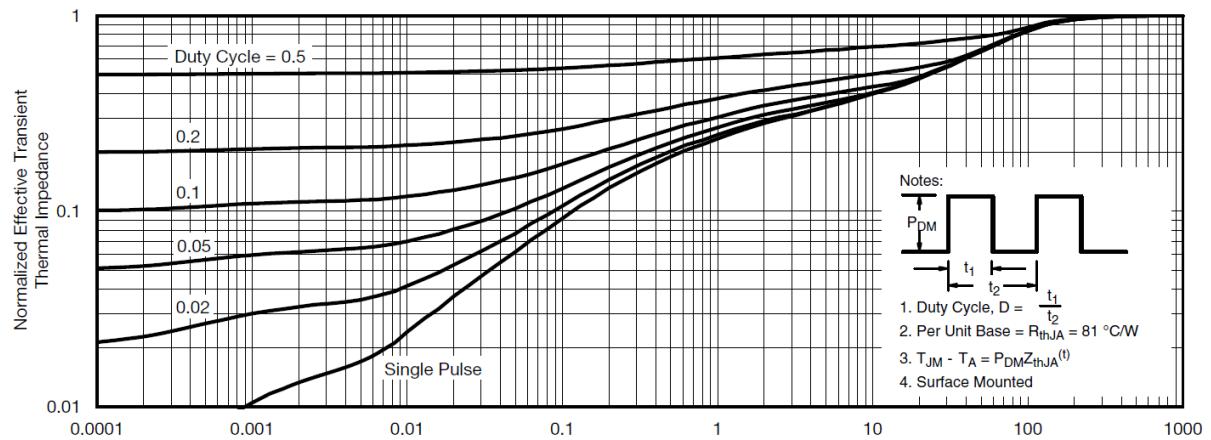


Single Pulse Power, Junction-to-Ambient

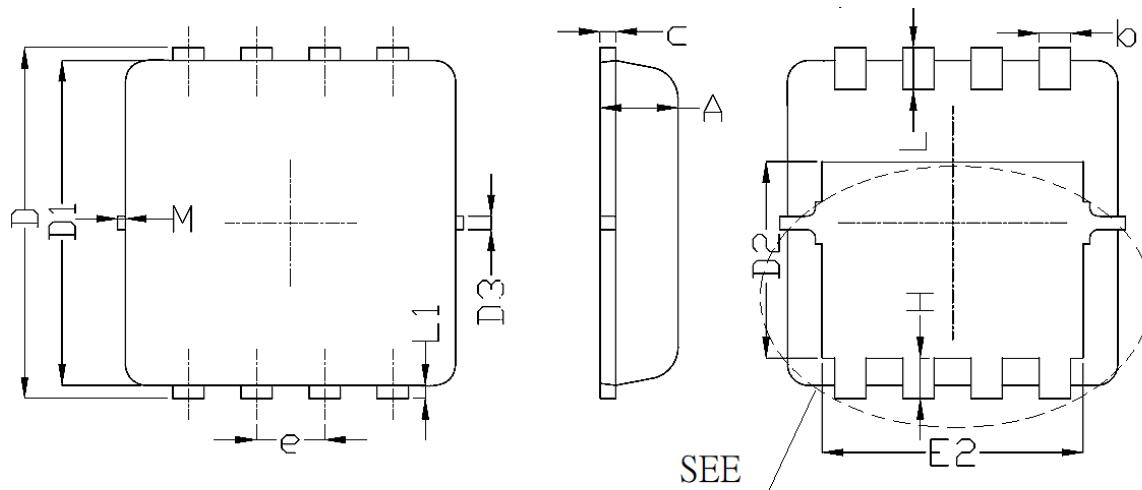


Safe Operating Area, Junction-to-Ambient

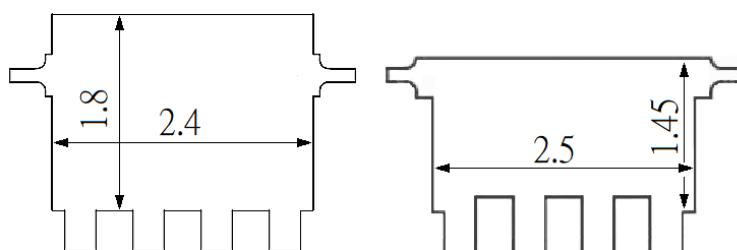
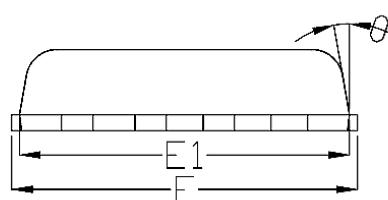
Typical Electrical and Thermal Characteristics



Package Information



SEE
DETAIL



OPTION 1

OPTION 2

DETAIL

SYMBOL	DIMENSIONS IN MILLIMETERS		
	MIN	NOM	MAX
A	0.7	0.775	0.85
b	0.25	0.3	0.35
c	0.1	0.15	0.25
D	3.15	3.3	3.4
D1	2.95	3.1	3.2
D2	1.7	1.8	1.93
D3		0.13	
E	3.05	3.25	3.35
E1	2.95	3.15	3.2
E2	2.3	2.4	2.55
e	0.65 BSC		
H	0.33	0.43	0.53
L	0.3	0.4	0.5
L1	0.08	0.13	0.18
θ	-	10°	12°
M	-	-	0.15